

Form PTO-1449

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LIST OF PATENTS AND PUBLICATIONS FOR
APPLICANT'S INFORMATION DISCLOSURE STATEMENT

APPLICANT

Christian HENTSCHEL et al

FILING DATE

Herewith

GROUP

2112

(Use several sheets if necessary)

REFERENCE DESIGNATION

U.S. PATENT DOCUMENTS

EXAMINER INITIAL	•	DOCUMENT NUMBER	DATE	NAME

FOREIGN PATENT DOCUMENT

		DOCUMENT NUMBER	DATE	NAME	TRANSLATION YES NO
IA		EP 0536538A2	04/14/1993	Hewlett-Packard Company	N/A
IA		EP 0654657A2	05/24/1995	AT & T Corp.	N/A

OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, etc.)

IA	Rex M. Craig et al, "High-Resolution, Nonmechanical Approach to Polarization-Dependent Transmission Measurements", Journal of Lightwave Technology, Vol. 16, No. 7, July 1998, pp 1285-1294		
IA	B.L. Heffner, "Deterministic, Analytically Complete Measurement of Polarization-Dependent Transmission Through Optical Devices", IEEE Photonics Technology Letters, Vol. 4, No. 5., May 1992, pp 451-454		
IA	Christian Hentschel et al, "PDL Measurements using the Agilent 8169A Polarization Controller" Product Note, Agilent Technologies, January 9, 2002, pp 1-14		
IA	"Polarization-dependent loss measurements using modular test system configurations", Product Note, Agilent Technologies, 1996, pp 1-14		
IA	K. Bohm et al, "Performance of Lyot Depolarizers with Birefringent Single-Mode Fibers", Journal of Lightwave Technology, Vol. LT-1, No. 1, March 1983, pp 71-74		
IA	EP Search Report, 24 June 2003		
EXAMINER	/Iyabo Alli/	DATE CONSIDERED	01/10/2007

* Copies of these references are not enclosed Pursuant to 37 CFR 1.98(d). (See accompanying IDS)